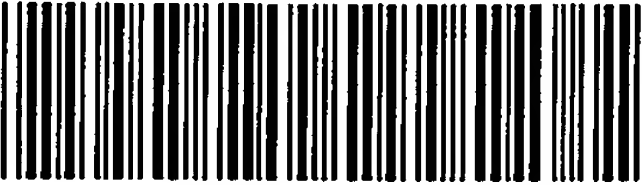


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/790,803	TANAHASHI ET AL.	
	Examiner	Art Unit	
	Alain L. Bashore	1762	

SEARCHED			
Class	Subclass	Date	Examiner
427	599, 598, 128	9/18/2005	AB

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (Attached)	9/18/2005	AB